Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ( $\pi$ -MOS $\overline{W}$ )

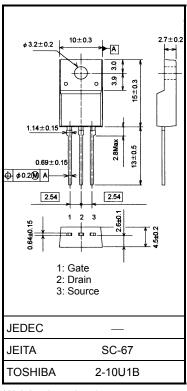
# **TK14A55D**

### **Switching Regulator Applications**

- Low drain-source ON-resistance: RDS (ON) = 0.31  $\Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 6.5 \text{ S (typ.)}$
- Low leakage current:  $I_{DSS} = 10 \mu A \text{ (max) (V}_{DS} = 550 \text{ V)}$
- Enhancement mode:  $V_{th} = 2.0 \text{ to } 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA)}$

#### Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	550	V	
Gate-source voltage		V <sub>GSS</sub>	±30	V	
Drain current	DC (Note 1)	I <sub>D</sub>	14	А	
	Pulse (t = 1 ms) (Note 1)	I <sub>DP</sub>	56		
Drain power dissipati	on (Tc = 25°C)	P <sub>D</sub>	50	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	E <sub>AS</sub> 521		
Avalanche current		I <sub>AR</sub>	14	А	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	5.0	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55 to 150	°C	



Weight: 1.7 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	2.5	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	62.5	°C/W

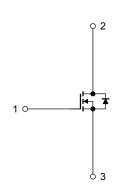
Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C (initial), L = 4.6 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AR}$  = 14 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.

**Internal Connection** 



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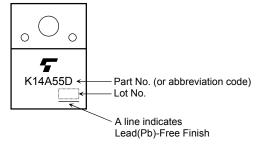
## **Electrical Characteristics (Ta = 25°C)**

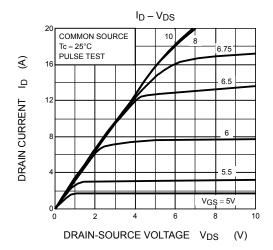
Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I <sub>GSS</sub>	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±1	μΑ
Drain cut-off current		I <sub>DSS</sub>	V <sub>DS</sub> = 550 V, V <sub>GS</sub> = 0 V		_	10	μΑ
Drain-source brea	akdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	550	_	_	V
Gate threshold vo	oltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	_	4.0	V
Drain-source ON	-resistance	R <sub>DS</sub> (ON)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7 A	_	0.31	0.37	Ω
Forward transfer	admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7 A	1.8	6.5	_	S
Input capacitance		C <sub>iss</sub>		_	2300	_	
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	10	_	pF
Output capacitance		C <sub>oss</sub>	]	_	250	_	
Switching time	Rise time	t <sub>r</sub>	10 V		50	_	
	Turn-on time	t <sub>on</sub>	$\begin{array}{c c}  & & & \\  & & & &$	_	100	_	ns
	Fall time	t <sub>f</sub>			25		
	Turn-off time	t <sub>off</sub>	Duty $\leq$ 1%, $t_W = 10 \mu s$	_	140	_	
Total gate charge		Qg		_	40	_	
Gate-source charge		Q <sub>gs</sub>	V <sub>DD</sub> ≈ 400 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 14 A	_	25	_	nC
Gate-drain charge		Q <sub>gd</sub>	]	_	15	_	

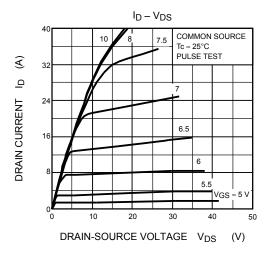
## Source-Drain Ratings and Characteristics (Ta = 25°C)

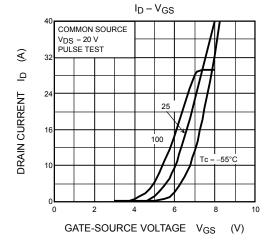
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	14	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_	_	56	Α
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 14 A, V <sub>GS</sub> = 0 V	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 14 A, V <sub>GS</sub> = 0 V,	_	1600	_	ns
Reverse recovery charge	Q <sub>rr</sub>	dI <sub>DR</sub> /dt = 100 A/μs	_	20	_	μС

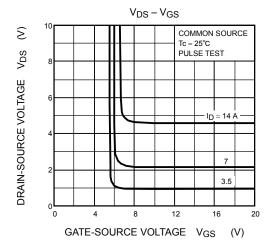
## Marking

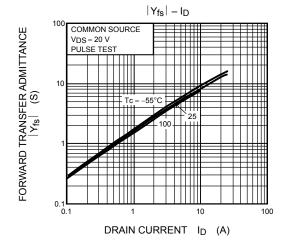


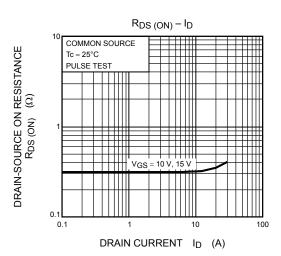




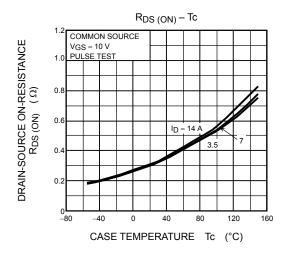


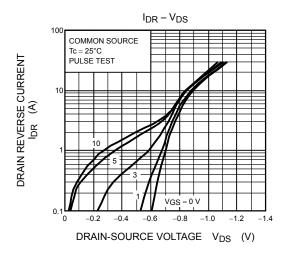


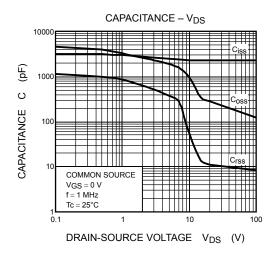


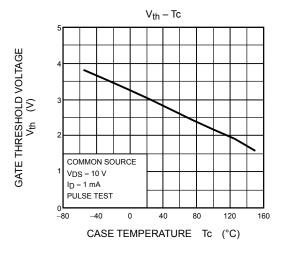


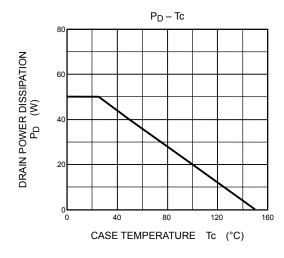
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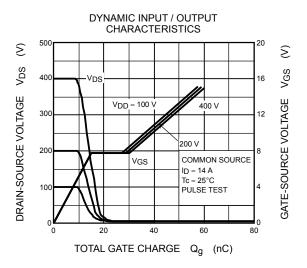




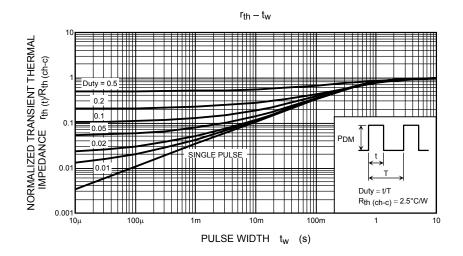


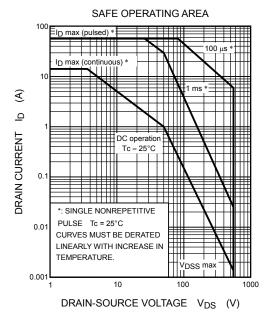


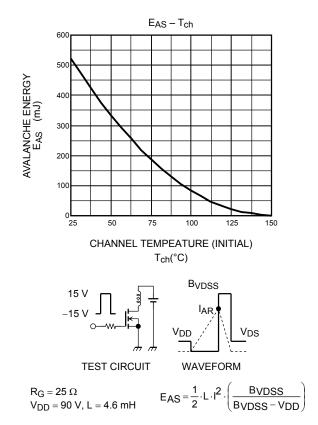




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